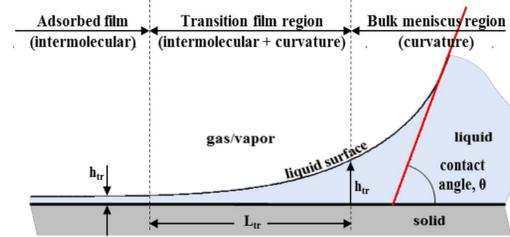


Guess free evaporation modeling without adsorbed film constraints

Kishan Bellur*, Ezequiel F Medici, Chang Kyoung Choi, James Hermanson and Jeffrey S. Allen

Kinetic Model of Phase Change

$$\dot{m}'' = \frac{2\alpha}{2-\alpha} \sqrt{\frac{m}{2\pi k_b}} \left(\frac{P_{li}}{\sqrt{T_i}} - \frac{P_{vi}}{\sqrt{T_v}} \right)$$



Planar interface:
Maxwellian Distribution
with drift velocity

Curved interface:
Pressure and
temperature variations
result in
non-uniform evaporation

$$\dot{m}'' = \frac{2\alpha}{2-\alpha} \left(\frac{M}{2\pi RT_i} \right)^{1/2} \left[\frac{p_v M h_{fg}}{RT_v T_i} (T_i - T_v) - \frac{v_l p_v}{RT_i} (\Pi + \sigma \kappa) \right]$$

Thermal

Mechanical

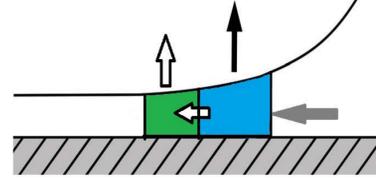
α : fraction of molecules that undergo phase change

Thin film evaporation

Lubrication Approximation

Interface Curvature

Start: Bulk meniscus
End: Adsorbed film



Disjoining Pressure

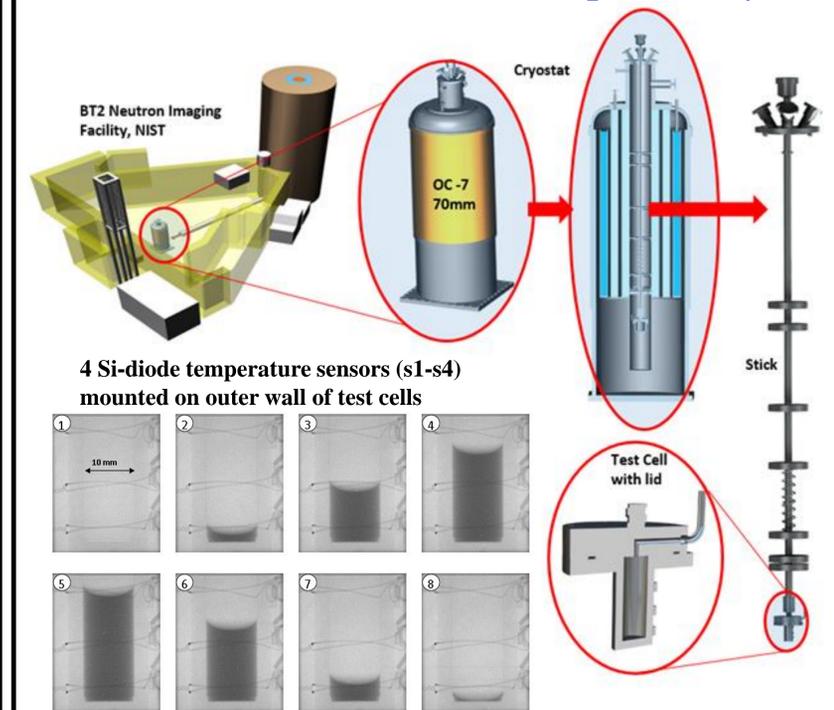
$$\Pi = -\frac{A}{h^3}$$

Combine mass, momentum and energy equations with Kinetic Model:

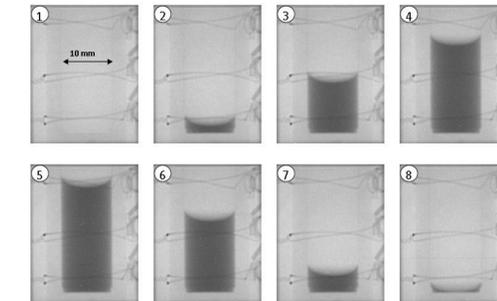
$$h_{xxx} - \frac{3h_{xx}^2 h_x}{1+h_x^2} - \frac{h_{xx} h_x}{r_{ij} - h} + \frac{h_x (1+h_x^2)}{(r_{ij} - h)^2} + \frac{\gamma}{\sigma} \left(\frac{1+h_x^2}{r_{ij} - h} + h_{xx} \right) \frac{dT_i}{dx} + \frac{1}{\sigma} (1+h_x^2)^{1/2} \left(\frac{dp_i}{dx} + \frac{d\Pi}{dx} \right) = 0$$

- 1D cylindrical co-ordinates
- Reversed integration path
- BC tuning is not necessary
- Non-uniform wall temperature
- Thermocapillary accounted

Cryo/neutron experiments with LH₂ and LCH₄



4 Si-diode temperature sensors (s1-s4)
mounted on outer wall of test cells



Multi-scale model of phase change

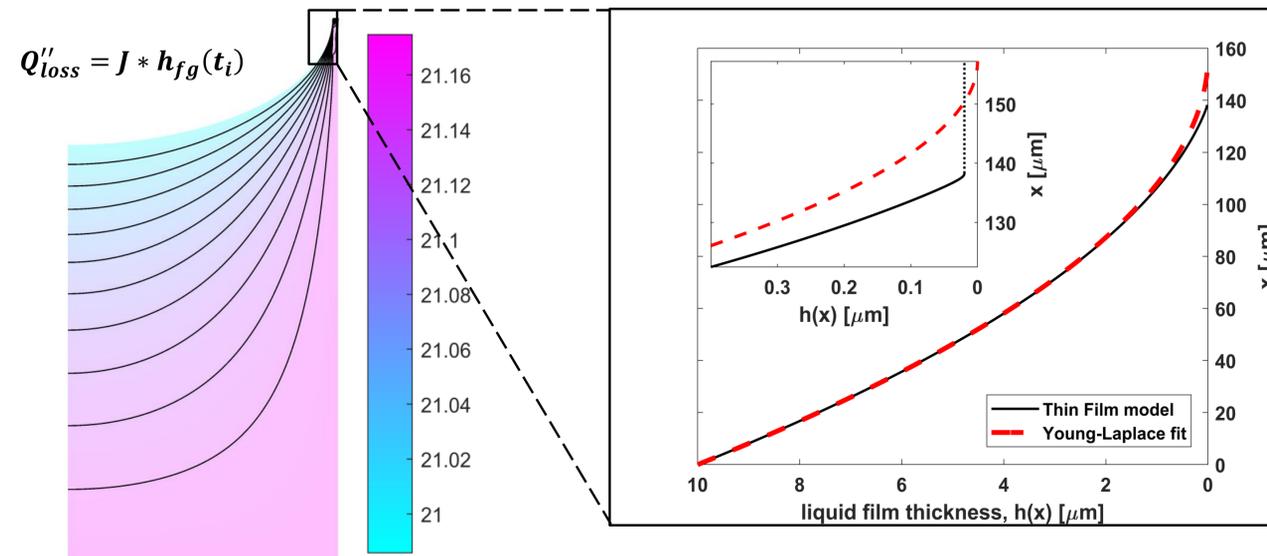
Macro-scale submodel (2D FEA)

+

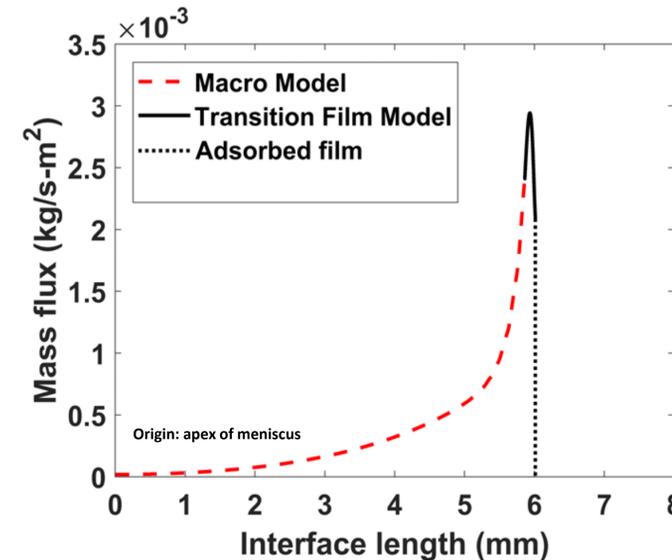
Thin film evaporation model

=

Coupled multi-scale model



Results with LH₂ saturated at 121 kPa in a 10 mm Al 6061 cell



Inputs

Θ, Bo, T_{wall}

Output

Mass flux
distribution

- Integrate for total evaporation rate
- Compare with Experimental rate
- Iterate on α to match

- Bulk meniscus accounts for 78-95%
- Adsorbed film not non-evaporating (<1%)
- Flux distribution changes with vapor pressure



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References:

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- [3] Bellur, PhD Dissertation, 2018. [LINK](#)

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